

INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Multiple sheets used when necessary)</i>	Application No.	10/807,128
	Filing Date	March 24, 2004
	First Named Inventor	Lin et al.
	Art Unit	2871
SHEET 1 OF 1		Examiner Michael H. Caley
		Attorney Docket No. QCO.086A/061118

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1	6,365,229	4/2/2002	Robbins	
	2	2001-0055146	12/27/2001	Atobe et al.	
	3	2004-0163472	8/26/2004	Nagahara	
	4	2004-0173886	9/9/2004	Carley	
	5	2005-0093134	5/5/2005	Tarn	

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
	6	EP 0 822 570	2/4/1998	Motorola Inc.		
	7	WO 03/084861	10/16/2003	Koninkl Philips		

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹
	8	Miles, MEMS-based interferometric modulator for display applications, Proceedings of the SPIE, Micromachined Devices and Components V, September 1999, pp. 20-28	
	9	Stark et al., An integrated process for post-packaging release and vacuum sealing of electroplated nickel packages, Transducers, 12th International Conference on Solid-State Sensors, Actuators and Microsystems, 2003, pp. 1911-1914	

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Examiner Signature	/Michael Caley/	Date Considered	07/10/2008
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*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /MC/
T¹ - Place a check mark in this area when an English language Translation is attached.